# **PC401**

#### ■ Features

- 1. Mini-flat package
- 2. "High" output during light emission
- 3. Isolation voltage between input and output  $(V_{iso}: 3750V_{rms})$
- 4. TTL and LSTTL compatible output
- 5. Recognized by UL(No.64380)

## ■ Applications

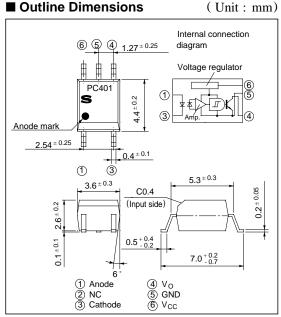
- 1. Hybrid substrate which requires high density mounting
- 2. Personal computers, office computers and peripheral equipment
- 3. Electronic musical instruments

## ■ Package Specifications

Model No.	Package specifications	Diameter of reel	Tape width	
PC401	Taping package ( Net : 3 000pcs. )	370mm	12mm	
PC401T	Taping package (Net: 750pcs.)	178mm	12mm	
PC401Z	Sleeve package (Net: 100pcs.)	-	-	

# **Compact, Surface Mount Type OPIC Photocoupler**

## ■ Outline Dimensions

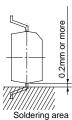


\* "OPIC" (Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and signalprocessing circuit integrated onto a single chip.

# ■ Absolute Maximum Ratings

 $(Ta = 25^{\circ}C)$ 

	Parameter	Symbol	Rating	Unit	
Input	Forward current	$I_F$	50	mA	
	Reverse voltage	V <sub>R</sub>	6	V	
	Power dissipation	P	70	mW	
	Supply voltage	V <sub>CC</sub>	16	V	
Ovetweet	High level output voltage	V OH	16	V	
Output	Low level output current	IoL	50	mA	
	Power dissipation	Po	130	mW	
To	Total power dissipation		150	mW	
*1 Iso	*1 Isolation voltage		3 750	V <sub>rms</sub>	
Op	Operating temperature		- 25 to + 85	°C	
Storage temperature		T stg	- 40 to + 125	°C	
*2 Soldering temperature		T sol	260	°C	



<sup>\*1</sup> AC for 1 minute, 40 to 60% RH

<sup>\*2</sup> For 10 seconds

## **■** Electro-optical Characteristics

( $Ta = 0 \text{ to} + 70^{\circ}\text{C}$  unless otherwise specified.)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Input	Forward voltage		V <sub>F</sub>	$I_F = 4mA$	-	1.1	1.4	V
				$I_F = 0.3 \text{mA}$	0.7	1.0	-	
	Reverse current		$I_R$	$Ta = 25^{\circ}C, V_R = 3V$	-	1	10	μΑ
	Terminal capacitance		Ct	$Ta = 25^{\circ}C, V = 0, f = 1kHz$	-	30	250	pF
Output	Operating supply voltage		V <sub>cc</sub>		3	-	15	V
	Low level output voltage		V <sub>OL</sub>	$I_F = 0, V_{CC} = 5V, I_{OL} = 16mA$	-	0.2	0.4	V
	High level output current		Іон	$I_F = 4mA$ , $V_{CC} = V_O = 15V$	-	1	100	μΑ
	Low level supply current		I <sub>CCL</sub>	$I_F = 0, V_{CC} = 5V$	-	2.5	5.0	mA
	High level supply current		Icch	$I_F = 4mA, V_{CC} = 5V$	-	2.7	5.5	mA
	*3 "H→L" threshold		I FHL	$Ta = 25^{\circ}C$ , $V_{CC} = 5V$ , $R_L = 280\Omega$	0.4	0.8	-	mA
	input current			$V_{\rm CC} = 5$ V, $R_{\rm L} = 280\Omega$	0.3	1	-	
	*4 "L→H" threshold		I <sub>FLH</sub>	$Ta = 25^{\circ}C$ , $V_{CC} = 5V$ , $R_L = 280\Omega$	-	1.1	2.0	mA
Transfer characteristics	input current			$V_{CC} = 5V, R_L = 280\Omega$	-	-	4.0	
	*5Hysteresis		I FHL /I FLH	$V_{CC} = 5V, R_L = 280\Omega$	0.5	0.7	0.9	
	Isolation resistance		R <sub>ISO</sub>	Ta = 25°C,DC500V,40 to 60% RH	5 x 10 <sup>10</sup>	$10^{11}$	-	Ω
	*6 Response time	"H→L" propagation delay time	t PHL		-	2	6	
		"L→H" propagation delay time	t PLH	$Ta = 25^{\circ}C, V_{CC} = 5V$	-	1	3	
		Fall time	$t_{\mathrm{f}}$	$R_L = 280\Omega$ , $I_F = 4mA$	-	0.05	0.5	μs
		Rise time	$t_{\rm r}$		-	0.1	0.5	

<sup>\*3</sup> I FHL represents forward current when output gose from high to low.

## **Test Circuit for Response Time**

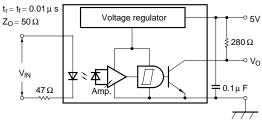
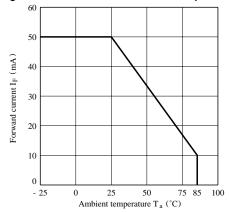


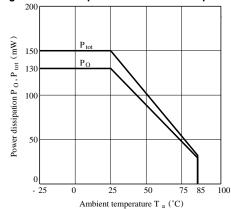
Fig. 1 Forward Current vs. Ambient Temperature



V<sub>IN</sub> t<sub>PHL</sub> - 50%

V<sub>O</sub> t<sub>PHL</sub> - 90% V<sub>O</sub> V<sub>O</sub> V<sub>O</sub>

Fig. 2 Power Dissipation vs. Ambient Temperature



<sup>\*4</sup> I FLH represents forward current when output goes from low to high.

<sup>\*5</sup> Hysteresis stands for  $I_{FHL}$  /I  $_{FLH}$  .

<sup>\*6</sup> Test circuit for response time is shown below.

Fig. 3 Forward Current vs. Forward Voltage

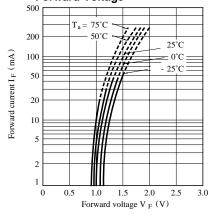


Fig. 5 Relative Threshold Input Current vs. Ambient Temperature

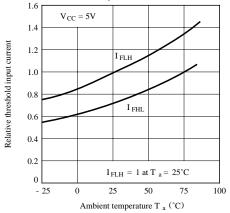


Fig. 7 Low Level Output Voltage vs.

Ambient Temperature

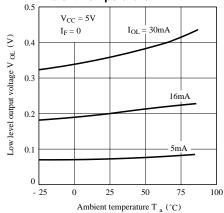


Fig. 4 Relative Threshold Input Current vs. Supply Voltage

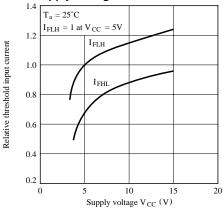


Fig. 6 Low Level Output Voltage vs. Low Level Output Current

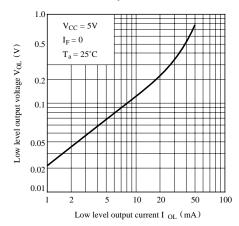


Fig. 8 High Level Output Current vs. Forward Current

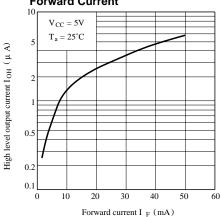


Fig. 9 High Level Output Current vs.
Ambient Temperature

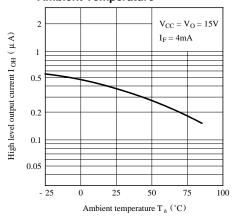


Fig.11 Propagation Delay Time vs. Forward Current

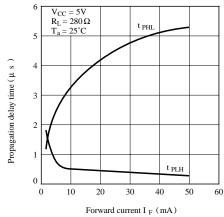


Fig.10 Supply Current vs.

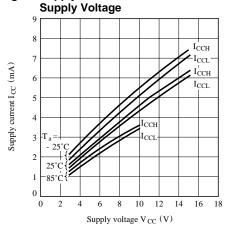
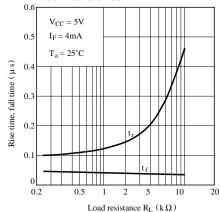


Fig.12 Rise Time, Fall Time vs. Load Resistance



## ■ Preautions for Use

- (1) It is recommended that a by-pass capacitor of more than  $0.01\mu$  F is added between  $V_{cc}$  and GND near the device in order to stabilize power supply line.
- (2) Handle this product the same as with other integrated circuits against static electricity.
- (3) As for other general cautions, refer to the chapter "Precautions for Use"

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